

**Search Notes**

Application/Control No.

10/542,556

Examiner

Tuyen Q. Tra

Applicant(s)/Patent under  
Reexamination

FEHN ET AL.

Art Unit

2873

**SEARCHED**

Class	Subclass	Date	Examiner
359	322 245 247 248 252 254 257	8/16/2007	TT
385	8 3	8/16/2007	TT
372	12	8/16/2007	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as	above	8/16/2007	TT
USPAT and USPG-PUB		8/16/2007	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
TEXT SEARCH ON EAST (USPAT, USPG-PUB, JPO, EPO, DERWENT) INVENTIVE SEARCH	8/16/2007	TT
INTERFERENCE SEARCH HISTORY PRINTOUT	8/16/2007	TT